

<b>Notice of References Cited</b>	Application/Control No. 10/767,248	Applicant(s)/Patent Under Reexamination. TRAN ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,631,606	05-1997	Tran, Hieu V.	330/253
*	B	US-6,304,141	10-2001	Kennedy et al.	330/253
*	C	US-6,137,355	10-2000	Sevic et al.	330/51
	D	US-5,175,508	12-1992	Gingrich et al.	330/84
	E	US-6,121,817	09-2000	Yang et al.	327/355
	F	US-6,181,204	01-2001	Smith et al.	330/261
	G	US-5,604,464	02-1997	Hwang et al.	330/253
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

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